Form	PT	O-1449 (modified)	DOCKET NO: 5150-63000		SERIAL NO: 10/010,829		
List of l	Paten	ts and Publications /	6	\			
For Applicant's Information			17.00		1		
Disclosure Statement			MR ST				
(Use several sheets if necessary)			PATENT & TRADE		<u></u>		
101	PE		APPLICANT: Schmit et al.				
FEB 0 3 2005 88			FILING DATE: November 13, 2001			GROUP: 2121	
			S. PATENT DOCUMENTS				
- V	ADEMA			NAME	CLASS	SUB	FILING DATE IF
EXAM. INITIALS	REF.	DOCUMENT NUMBER	DATE	NAIVIE	CLASS	CLASS	APPROPRIATE
	A1	5,133,045	07/21/1992	Gaither et al.	7/	11/	
Crif		•			700	46	
(1.0)	A2	6,067,584	05/23/2000	Hayles et al.	710	10	
6.9	A3	6,096,094	08/01/2000	Kay et al.	717	168	
6.9	A4	5,926,775	07/20/1999	Brumley et al.	702	127	
60	Ą5	4,812,996	03/14/1989	Stubbs	701	3_	
(2.0)	A6	4,868,785	09/19/1989	Jordan et al.	345	440	
68	A7	4,884,228	11/28/1989	Stanley et al.	702	123	II V
C.J.	A8	5,136,705	08/04/1992	Stubbs et al.	714	27	
Gi	A9	5,155,836	10/13/1992	Jordan et al.	703	23	
(2)	A10	5,481,741	01/02/1996	McKaskle et al.	345	522	
(px)	A11	5,630,164	05/13/1997	Williams et al.	703	24	
CI	A12	5,812,394	09/22/1998	Lewis et al.	700	17	
6.1	A13	5,991,537	11/23/1999	McKeon et al.	717	115	
6.1	A14	6,098,028	08/01/2000	Zwan et al.	702	120	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
	1	National Instruments "T	he Measuremen	t and Automation Catalog 2	2001", C	opyright 20	000, pgs. 252-
					ŀ	. 1	
EXAMINER: GROGG DAVIS DATE CONSIDERED: 1/24 04							
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